## IN THE LINITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Shunpei Yamazaki et al. Art Unit : 2629

Serial No.: 09/504,235 Examiner: David L. Lewis Filed February 15, 2000 Conf. No.: 7610

Filed : February 15, 2000 Conf. No. : 7610
Title : METHOD OF MANUFACTURING A SEMICONDUCTOR DEVICE

MAIL STOP AF

Commissioner for Patents P.O. Box 1450

Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(Z)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

Submitted herewith is an English translation of the following foreign language references, or portions thereof:

Desig. ID	Source
AO	JAPAN 04-2472724 - English shstract provided by esp@conet Worldwide (2006) and family to U.S. Patent Nos. 5,451,858 (Desig. ID "AC"), 5,514,878 (Desig. ID "AC"), 5,614,732 (Desig. ID "AC"), 5,849,601 (Desig. ID "AC"), 5,859,445 (Desig. ID "AE"), 6,011,277 (Desig. ID "AC"), 6,023,075 (Desig. ID "AC"), 6,023,075 (Desig. ID "AC"), 6,023,075 (Desig. ID "AC"), 6,023,075 (Desig. ID "AC"), 7,067,344 (Desig. ID "AC"), 7,067,34

This statement is being filed after a final Office action or a Notice of Allowance, but before payment of the issue fee. With the exception of references "AA" to "AN", each item of information in this statement (i) was cited in a communication from a foreign patent office in a counterpart foreign application, the communication being dated November 7, 2006, which is not more than three months prior to the filing of this statement, and (ii) was not first cited in any communication from a foreign patent office in a counterpart application which was more than three months prior to the filing date of this statement. References "AA" to "AN" are Englishlanguage documents corresponding to reference "AO" as noted above, and are cited in accordance with MPEP 609/IIII/B(S).

Attorney's Docket No.: 07977-008004 / US2938D1D2

Applicant : Shunpei Yamazaki et al. Serial No. : 09/504,235 Filed : February 15, 2000

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The fee in the amount of \$180 for payment of the late submission fee of \$1.17(p) is being paid concurrently herewith on the Electronic Filing System (EFS) by way of Deposit Account authorization. Please apply any other charges or credits to Deposit Account No. 06-1050.

Date: November 20, 2006

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Respectfully submitted,

Substitute Form PTO-1449 U.S. Department of Commerce (Modified) Patent and Trademark Office		Attorney's Docket N 07977-008004	2.	Application No. 09/504,235				
Information Disclosure Statement by Applicant				Applicant Shunpei Yamazaki et al.				
(Use several sheets if necessary) 37 CFR §1.96(b))			Fiting Date February 15, 2000		Group Art Unit 2629			
			U.S. Patent	Documents				
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate	
	AA	5,453,858	09/26/1995	Yamazaki			02/03/1995	
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Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Trans	lation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AO	04-242724	08/31/1992	JAPAN			AB	
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)				
Examiner	Desig.	·		
Initial	ID	Document		
	AQ			
	AR			

Examiner Signature	Date Considered
EXAMINER: Initials of atom considered. Draw line through of atom if not	